

Application/Control No.	Applicant(s)/Patent under Reexamination		
09/711,791	TALLURI, SRIKRISHNA		
Examiner	Art Unit		
Quoc A Tran	2176		

SEARCHED					
Class	Subclass	Date	Examiner		
715	501	11/18/2005	8		
715	511	11/18/2005	AY		
707	204	11/18/2005	20		
707	10	11/18/2005	1		
Updated	Above	7/22/2006	8		

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
715	740	7/22/2006	#		
715	511	11/18/2006	(3)		
705	7	07/22/2006	8		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST (US-PAT, US-PGPUB, EPO, JPO, DERWENT, IBM_TDB, USOCR) See Search Histoty Printout	11/18/2005	Ø		
IEEE DataBase see Search History Printout	11/18/2005	D		
WayBack Machine Database see Search History Printout	11/18/2005	A		
ACM Digital Library see Search History Printout	11/18/2005	0		
WayBack Machine Database see Search History Printout	7/22/2006	D		
EAST (US-PAT, US-PGPUB, EPO, JPO, DERWENT, IBM_TDB, USOCR) See Search Histoty Printout	7/22/2006	ð		
EAST (USPGPUB) Interference Search-See Search History	7/22/2006	D		
STIC EIC-2100 Search See Search History	7/22/2006	H		